Notice of References Cited

Application/Control No. 10/005,113	Reexamination	Applicant(s)/Patent Under Reexamination CARRICO ET AL.		
Examiner	Art Unit			
David G. Cervetti	2136	Page 1 of 4		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,811,288	03-1989	Kleijne et al.	365/52
*	В	US-5,469,557	11-1995	Salt et al.	711/103
*	С	US-5,623,637	04-1997	Jones et al.	711/164
*	D	US-5,768,382	06-1998	Schneier et al.	380/251
*	Ε	US-5,778,071	07-1998	Caputo et al.	713/159
*	F	US-5,987,134	11-1999	Shin et al.	713/159
*	G	US-6,105,133	08-2000	Fielder et al.	713/169
*	Н	US-6,169,745 B1	01-2001	Liu et al.	370/463
*	1	US-6,292,898	09-2001	Sutherland, Mark J.	726/34
*	J	US-6,371,376	04-2002	Dan, Ho J.	235/486
*	К	US-6,401,206	06-2002	Khan et al.	713/176
*	L	US-6,609,199	08-2003	DeTreville, John	713/172
*	М	US-6,721,891	04-2004	Borza, Stephen J.	726/20

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	ø					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Hartel et al., Arithmetic Co-processors for Public-key Cryptography: The State of the Art, September 1996.
	v	3Com, 3Com Etherlink and Etherlink Server, 10/100 PCI NICs with 3XP Processor, 2000, http://www.cyclone.co.nz/Downloads/PDF/3CR990.pdf
	w	SIGNALMagazine, Cyberguardian keeps hackers, insider threats at bay, June 2001, http://www.securecomputing.com/pdf/HK_Cyber_June_exp.pdf
	х	3Com, EtherLink® 10/100 PCI Network Interface Card with 3XP processor User Guide, August 1999, 3Com, http://support.3com.com/infodeli/tools/nic/3cr990/usrguide.pdf

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Application/Control No. 10/005,113 Applicant(s)/Patent Under Reexamination CARRICO ET AL. Examiner David G. Cervetti Art Unit Page 2 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,811,288 A	03-1989	Kleijne et al.	· 713/194
*	В	US-5,060,261 A	10-1991	Avenier et al.	713/194
*	С	US-5,159,629 A	10-1992	Double et al.	713/194
*	D	US-5,629,981 A	05-1997	Nerlikar, Virupax M.	713/168
*	Е	US-5,826,015 A	10-1998	Schmidt, Thomas J.	726/23
*	F	US-6,185,507 B1	02-2001	Huber et al.	702/30
*	G	US-6,351,814 B1	02-2002	Batinic et al.	713/194
*	Н	US-6,438,429 B1	08-2002	Ho et al.	700/22
*	1	US-6,549,960 B1	04-2003	Allison et al.	710/29
*	J	US-6,564,333 B1	05-2003	Ho et al.	713/340
*	к	US-6,622,178 B1	09-2003	Burke et al.	710/15
*	L	US-6,915,124 B1	07-2005	Kiessling et al.	455/411
*	М	US-6,976,167 B2	12-2005	Nenashev, Michael A.	713/168

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U				
	٧				
	w	·			
	х				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No. 10/005,113	Reexaminati	Applicant(s)/Patent Under Reexamination CARRICO ET AL.	
Examiner	ner Art Unit		
David G. Cervetti	2136	Page 3 of 4	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,811,288 A	03-1989	Kleijne et al.	365/52
*	В	US-6,101,608 A	08-2000	Schmidt et al.	726/2
*	С	US-6,115,376 A	09-2000	Sherer et al.	370/389
*	D	US-6,311,276 B1	10-2001	Connery et al.	726/2
*	E	US-2002/0138549 A1	09-2002	Urien, Pascal	709/202
*	F	US-2002/0162026 A1	10-2002	Neuman et al.	713/201
*	G	US-2002/0174071 A1	11-2002	Boudou et al.	705/41
*	Н	US-2003/0086542 A1	05-2003	Urien, Pascal	379/93.01
*	1	US-6,606,709 B1	08-2003	Connery et al.	726/14
*	J	US-6,735,627 B2	05-2004	Urien, Pascal	709/223
*	К	US-6,839,756 B1	01-2005	Boudou et al.	709/225
*	L	US-6,851,052 B1	02-2005	Graveman, Richard F.	713/168
*	М	US-6,944,650 B1	09-2005	Urien, Pascal	709/217

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	V	·
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | CARRICO ET AL. | Examiner | David G. Cervetti | 2136 | Page 4 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,811,288 A	03-1989	Kleijne et al.	365/52
*	В	US-5,561,812 A	10-1996	Ravaux et al.	709/250
*	С	US-6,049,885 A	04-2000	Gibson et al.	713/324
*	D	US-2002/0083150 A1	06-2002	Minnick, Linden	709/216
*	Е	US-2002/0124092 A1	09-2002	Urien, Pascal	709/229
*	F	US-6,513,128 B1	01-2003	Wang et al.	713/600
*	G	US-2003/0051026 A1	03-2003	Carter et al.	709/224
*	Н	US-6,546,496 B1	04-2003	Wang et al.	713/322
*	ı	US-6,556,580 B1	04-2003	Wang et al.	370/412
*	J	US-6,553,441 B1	04-2003	Wang et al.	710/64
*	К	US-6,665,306 B1	12-2003	Thakur et al.	370/419
*	L	US-6,751,671 B1	06-2004	Urien, Pascal	709/229
*	М	US-6,760,781 B1	07-2004	Wang et al.	709/250

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages).
	U	
	>	
	V	
	х	

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.